

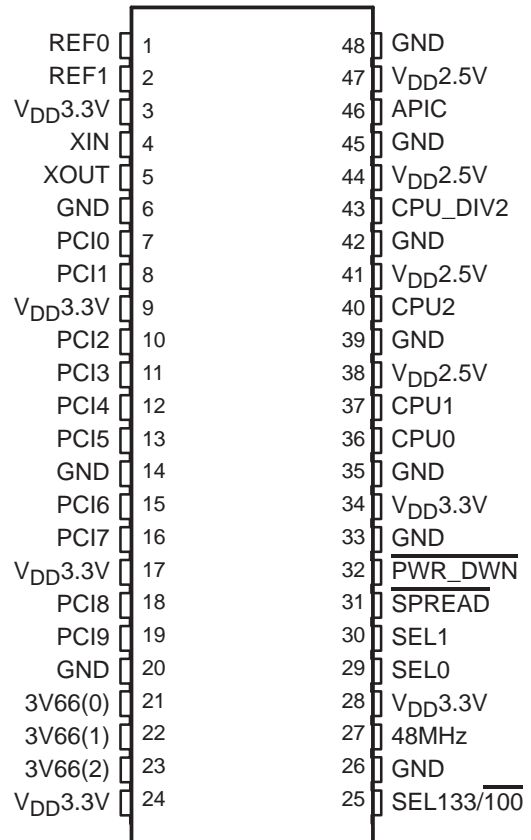
CDC921

133-MHz CLOCK SYNTHESIZER/DRIVER FOR PC MOTHERBOARDS WITH 3-STATE OUTPUTS

SCAS623 –MAY 27, 1999

- Generates Clocks for Pentium™ III Class Microprocessors
- Supports a Single Pentium III Microprocessor
- Uses a 14.318 MHz Crystal Input to Generate Multiple Output Frequencies
- Includes Spread Spectrum Clocking (SSC), 0.5% Downspread for Reduced EMI Performance
- Power Management Control Terminals
- Low Output Skew and Jitter for Clock Distribution
- Operates from Dual 2.5-V and 3.3-V Supplies
- Generates the Following Clocks:
 - 3 CPU (2.5 V, 100/133 MHz)
 - 10 PCI (3.3 V, 33.3 MHz)
 - 1 CPU/2 (2.5 V, 50/66 MHz)
 - 1 APIC (2.5 V, 16.67 MHz)
 - 3 3V66 (3.3 V, 66 MHz)
 - 2 REF (3.3 V, 14.318 MHz)
 - 1 48MHz (3.3 V, 48 MHz)
- Packaged in 48-Pin SSOP Package
- Designed for Use with TI's Direct Rambus™ Clock Generators (CDCR81, CDCR82, CDCR83)

DL PACKAGE
(TOP VIEW)



description

The CDC921 is a clock synthesizer/driver that generates CPU, CPU_DIV2, 3V66, PCI, APIC, 48MHz, and REF system clock signals to support computer systems with a single Pentium III class microprocessor.

All output frequencies are generated from a 14.318-MHz crystal input. Instead of a crystal, a reference clock input can be provided at the XIN input. Two phase-locked loops (PLLs) are used to generate the host frequencies and the 48-MHz clock frequency. On-chip loop filters and internal feedback eliminate the need for external components.

The host and PCI clock outputs provide low-skew and low-jitter clock signals for reliable clock operation. All outputs have 3-state capability, which can be selected via control inputs SEL0, SEL1, and SEL133/100.

The 48MHz clock can be independently disabled via the control inputs SEL0, SEL1, and SEL133/100. In this state, the 48-MHz PLL is disabled and the 48MHz clock is driven to high impedance to reduce component jitter.

The outputs are either 3.3-V or 2.5-V single-ended CMOS buffers. With a logic high-level on the PWR_DWN terminal, the device operates normally, but when a logical low-level input is applied, the device powers down completely with the outputs in a low-level output state.



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description (continued)

The CPU bus can operate at 100 MHz or 133 MHz. Output frequency selection is done with corresponding setting for SEL133/100 control input. The PCI bus frequency is fixed to 33 MHz.

Since the CDC921 is based on PLL circuitry, it requires a stabilization time to achieve phase lock of the PLL. This stabilization time is required after power up or after changes to the SEL inputs are made. With use of an external reference clock, this signal must be fixed-frequency and fixed-phase before the stabilization time starts.

Function Tables

SELECT FUNCTIONS

INPUTS			OUTPUTS							FUNCTION
SEL133/ 100	SEL1	SEL0	CPU	CPU_DIV2	3V66	PCI	48MHz	REF	APIC	
L	L	L	Hi-Z	Hi-Z	Hi-Z	Hi-Z	Hi-Z	Hi-Z	Hi-Z	3-state
L	L	H	N/A	N/A	N/A	N/A	N/A	N/A	N/A	Reserved
L	H	L	100 MHz	50 MHz	66 MHz	33 MHz	Hi-Z	14.318 MHz	16.67 MHz	48-MHz PLL off
L	H	H	100 MHz	50 MHz	66 MHz	33 MHz	48 MHz	14.318 MHz	16.67 MHz	48-MHz PLL on
H	L	L	TCLK/2	TCLK/4	TCLK/4	TCLK/8	TCLK/2	TCLK	TCLK/16	Test
H	L	H	N/A	N/A	N/A	N/A	N/A	N/A	N/A	Reserved
H	H	L	133 MHz	66 MHz	66 MHz	33 MHz	Hi-Z	14.318 MHz	16.67 MHz	48-MHz PLL off
H	H	H	133 MHz	66 MHz	66 MHz	33 MHz	48 MHz	14.318 MHz	16.67 MHz	48-MHz PLL on

ENABLE FUNCTIONS

INPUTS	OUTPUTS						INTERNAL	
PWR_DWN	CPU	CPU_DIV2	APIC	3V66	PCI	REF, 48MHz	CRYSTAL	VCOs
L	L	L	L	L	L	L	Off	Off
H	On	On	On	On	On	On	On	On

OUTPUT BUFFER SPECIFICATIONS

BUFFER NAME	V _{DD} RANGE (V)	IMPEDANCE (Ω)	BUFFER TYPE
CPU, CPU_DIV2, APIC	2.375 – 2.625	13.5 – 45	TYPE 1
48MHz, REF	3.135 – 3.465	20 – 60	TYPE 3
PCI, 3V66	3.135 – 3.465	12 – 55	TYPE 5

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Terminal Functions

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
3V66 [0–2]	21–23	O	3.3 V, Type 5, 66-MHz clock outputs
48MHz	27	O	3.3 V, Type 3, 48-MHz clock output
APIC	46	O	2.5 V, Type 2, APIC clock output at 16.67 MHz
CPU [0–2]	36, 37, 40	O	2.5 V, Type 1, CPU clock outputs
CPU_DIV2	43	O	2.5 V, Type 1, CPU_DIV2 clock output
GND	6, 14, 20, 26, 33, 35, 39, 42, 45, 48		Ground for PCI, 3V66, 48MHz, CPU, CPU_DIV2, APIC, REF [0–1] outputs and CORE
PCI [0–9]	7, 8, 10–13, 15, 16, 18, 19	O	3.3 V, Type 5, 33-MHz PCI clock outputs
PWR_DWN	32	I	Power down for complete device with outputs forced low
REF0, REF1	1, 2	O	3.3 V, Type 3, 14.318-MHz reference clock outputs
SEL0, SEL1	29, 30	I	LVTTL level logic select terminals for function selection
SEL133/100	25	I	LVTTL level logic select terminal for enabling 100/133 MHz
SPREAD	31	I	Disables SSC function
V _{DD} 2.5V	38, 41, 44, 47		Power for CPU, CPU_DIV2, and APIC outputs
V _{DD} 3.3V	3, 9, 17, 24, 28, 34		Power for the REF, PCI, 3V66, 48MHz outputs and CORE
XIN	4	I	Crystal input – 14.318 MHz
XOUT	5	O	Crystal output – 14.318 MHz

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spread spectrum clock (SSC) implementation for CDC921

Simultaneously switching at fixed frequency generates a significant power peak at the selected frequency, which in turn will cause EMI disturbance to the environment. The purpose of the internal frequency modulation of the CPU-PLL allows to distribute the energy to many different frequencies which reduces the power peak. A typical characteristic for a single frequency spectrum and a frequency modulated spectrum is shown in Figure 1.

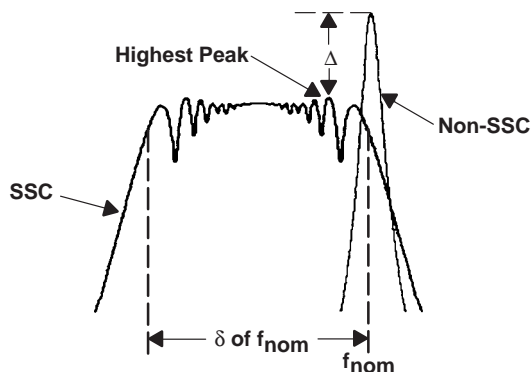


Figure 1. Frequency Power Spectrum With and Without the Use of SSC

The modulated spectrum has its distribution left hand to the single frequency spectrum which indicates a “down-spread modulation”.

The peak reduction depends on the modulation scheme and modulation profile. System performance and timing requirements are the limiting factors for actual design implementations. The implementation was driven to keep the average clock frequency closed to its upper specification limit. The modulation amount was set to approximately -0.5% .

In order to allow a downstream PLL to follow the frequency modulated signal, the bandwidth of the modulation signal is limited in order to minimize SSC induced tracking skew jitter. The ideal modulation profile used for CDC921 is shown in Figure 2.

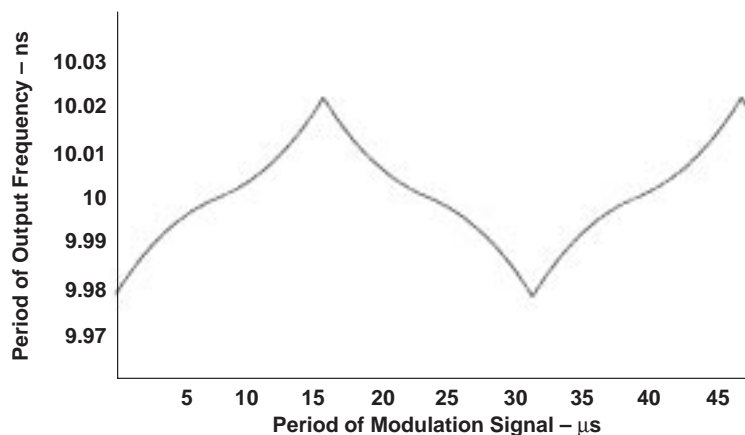
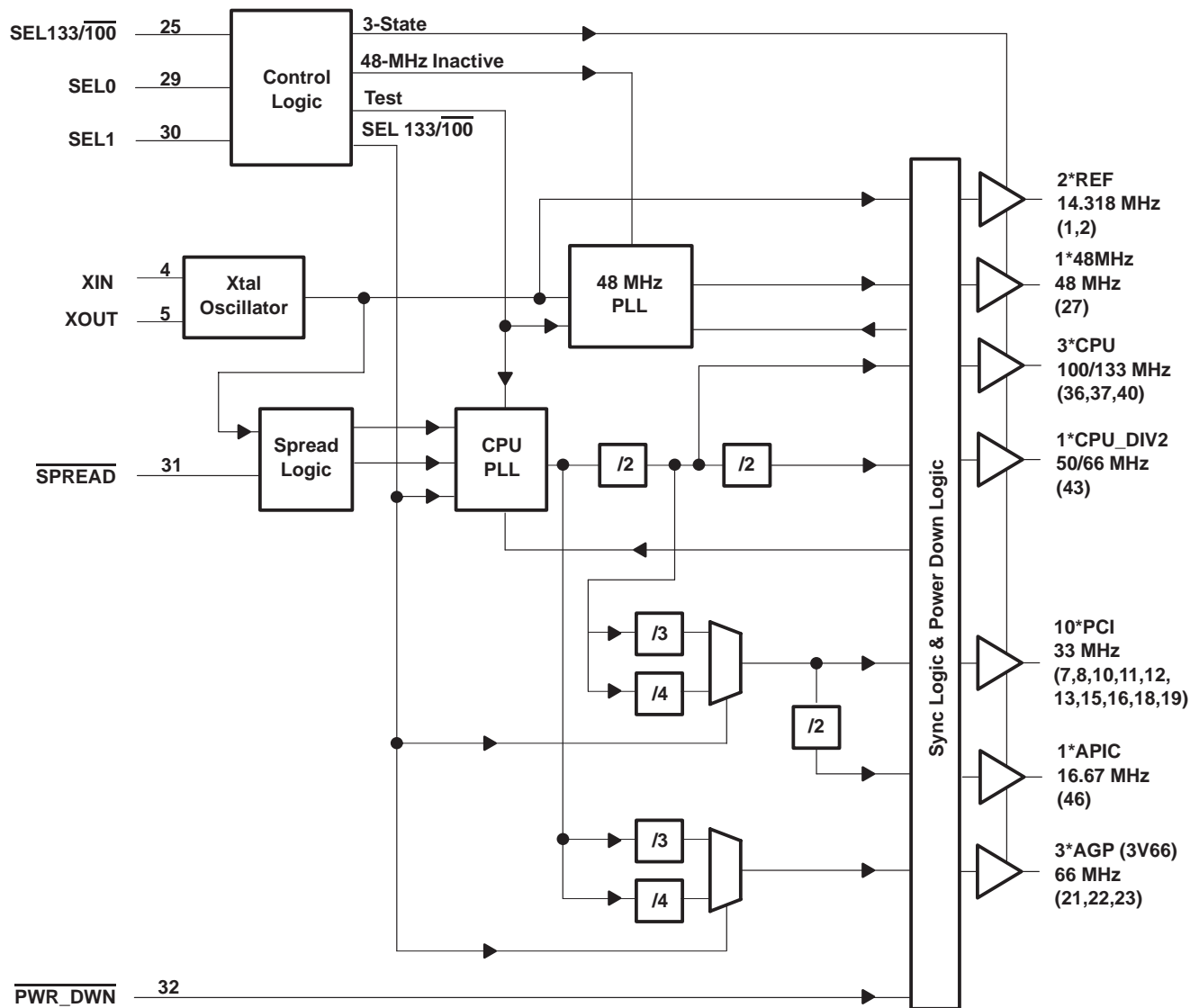


Figure 2. SSC Modulation Profile

CDC921 133-MHz CLOCK SYNTHESIZER/DRIVER FOR PC MOTHERBOARDS WITH 3-STATE OUTPUTS

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functional block diagram



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{DD}	–0.5 V to 4.6 V
Input voltage range, V_I (see Note 1)	–0.5 V to 4.6 V
Voltage range applied to any output in the high-impedance state or power-off state, V_O (see Note 1)	–0.5 V to $V_{DD} + 0.5$ V
Current into any output in the low state, I_O	$2 \times I_{OL}$
Input clamp current, I_{IK} ($V_I < 0$)	–18 mA
Output clamp current, I_{OK} ($V_O < 0$)	–50 mA
Operating free-air temperature range, T_A	–0°C to 85°C
Storage temperature range, T_{stg}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATNG	DERATING FACTORT ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING	$T_A = 85^\circ\text{C}$ POWER RATING
DL	1315.7 mW	10.53 mW/°C	842.1 mW	684.2 mW

† This is the inverse of the traditional junction-to-case thermal resistance ($R_{\theta JA}$) and uses a board-mounted device at 95°C/W.

recommended operating conditions (see Note 2)

		MIN	NOM†	MAX	UNIT
Supply voltage, V_{DD}	3.3 V	3.135		3.465	V
	2.5 V	2.375		2.625	
High-level input voltage, V_{IH}		2		$V_{DD} + 0.3$ V	V
Low-level input voltage, V_{IL}		GND – 0.3 V		0.8	V
Input voltage, V_I		0		V_{DD}	V
High-level output current, I_{OH}	CPUx, CPU_DIV2			–12	mA
	APIC			–12	
	48MHz, REFx			–14	
	PCIx, PCI_F, 3V66x			–18	
Low-level output current, I_{OL}	CPUx, CPU_DIV2			12	mA
	APIC			12	
	48MHz, REFx			9	
	PCIx, PCI_F, 3V66x			12	
Reference frequency, $f_{(XTAL)}^\ddagger$	Test mode		130		MHz
Crystal frequency, $f_{(XTAL)}^\S$	Normal mode	13.8	14.318	14.8	MHz
Operating free-air temperature, T_A		0		85	°C

NOTE 2: Unused inputs must be held high or low to prevent them from floating.

† All nominal values are measured at their respective nominal V_{DD} values.

‡ Reference frequency is a test clock driven on the XIN input during the device test mode and normal mode. In test mode, XIN can be driven externally up to $f_{(XTAL)} = 130$ MHz. If XIN is driven externally, XOUT is floating.

§ This is a series fundamental crystal with $f_O = 14.31818$ MHz.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V _{IK}	Input clamp voltage	V _{DD} = 3.135 V, I _I = -18 mA			-1.2	V
R _I	Input resistance	XIN, XOUT V _{DD} = 3.465 V, V _I = V _{DD} - 0.5 V	80		350	kΩ
I _{IH}	High-level input current	XOUT V _{DD} = 3.135 V, V _I = V _{DD} - 0.5 V		20	50	mA
		SEL0, SEL1, SPREAD V _{DD} = 3.465 V, V _I = V _{DD}		<10	10	μA
		PWR_DWN V _{DD} = 3.465 V, V _I = V _{DD}		<10	10	μA
		SEL133/100 V _{DD} = 3.465 V, V _I = V _{DD}		<10	10	μA
I _{IL}	Low-level input current	XOUT V _{DD} = 3.135 V, V _I = 0 V		-2	-5	mA
		SEL0, SEL1, SPREAD V _{DD} = 3.465 V, V _I = GND		<10	-10	μA
		PWR_DWN V _{DD} = 3.465 V, V _I = GND		<10	-10	μA
		SEL133/100 V _{DD} = 3.465 V, V _I = GND		<10	-10	μA
I _{OZ}	High-impedance-state output current	V _{DD} = max, V _O = V _{DD} or GND			±10	μA
I _{DD}	Supply current	V _{DD} = 2.625 V, All outputs = low, PWR_DWN = low		<20	100	μA
		V _{DD} = 2.625 V, All outputs = high		<20	100	μA
		V _{DD} = 3.465 V, All outputs = low, PWR_DWN = low		<50	200	μA
		V _{DD} = 3.465 V, All outputs = high		12	37	mA
I _{DD(Z)}	High-impedance-state supply current	V _{DD} = 2.625 V			1.4	mA
		V _{DD} = 3.465 V			30	
Dynamic I _{DD}		C _L = 20 pF, CPU = 133 MHz	V _{DD} = 3.465 V	114	156	mA
			V _{DD} = 2.625 V	44	60	
C _I	Input capacitance	V _{DD} = 3.3 V, V _I = V _{DD} or GND	3.3		5.8	pF
	Crystal terminal capacitance	V _{DD} = 3.3 V, V _I = 0.3 V	18	18.5	22.5	pF

† All typical values are measured at their respective nominal V_{DD} values.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

CPUx, CPU_DIV2, APIC (Type 1)

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V _{OH}	High-level output voltage	V _{DD} = min to max, I _{OH} = -1 mA	V _{DD} - 0.1 V			V
		V _{DD} = 2.375 V, I _{OH} = -12 mA	2			
V _{OL}	Low-level output voltage	V _{DD} = min to max, I _{OL} = 1 mA			0.1	V
		V _{DD} = 2.375 V, I _{OL} = 12 mA		0.18	0.4	
I _{OH}	High-level output current	V _{DD} = 2.375 V, V _O = 1 V	-26	-42		mA
		V _{DD} = 2.5 V, V _O = 1.25 V		-46		
		V _{DD} = 2.625 V, V _O = 2.375 V		-16	-27	
I _{OL}	Low-level output current	V _{DD} = 2.375 V, V _O = 1.2 V	27	57		mA
		V _{DD} = 2.5 V, V _O = 1.25 V		63		
		V _{DD} = 2.625 V, V _O = 0.3 V		23	43	
C _O	Output capacitance	V _{DD} = 3.3 V, V _O = V _{DD} or GND	5.8		8.5	pF
Z _O	Output impedance	High state V _O = 0.5 V _{DD} , V _O /I _{OH}	13.5	27	45	Ω
		Low state V _O = 0.5 V _{DD} , V _O /I _{OL}	13.5	20	45	

† All typical values are measured at their respective nominal V_{DD} values.

48MHz, REFx (Type 3)

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V _{OH}	High-level output voltage	V _{DD} = min to max, I _{OH} = -1 mA	V _{DD} - 0.1 V			V
		V _{DD} = 3.135 V, I _{OH} = -14 mA	2.4			
V _{OL}	Low-level output voltage	V _{DD} = min to max, I _{OL} = 1 mA			0.1	V
		V _{DD} = 3.135 V, I _{OL} = 9 mA		0.18	0.4	
I _{OH}	High-level output current	V _{DD} = 3.135 V, V _O = 1 V	-27	-41		mA
		V _{DD} = 3.3 V, V _O = 1.65 V		-41		
		V _{DD} = 3.465 V, V _O = 3.135 V		-12	-23	
I _{OL}	Low-level output current	V _{DD} = 3.135 V, V _O = 1.95 V	29	50		mA
		V _{DD} = 3.3 V, V _O = 1.65 V		53		
		V _{DD} = 3.465 V, V _O = 0.4 V		20	37	
C _O	Output capacitance	V _{DD} = 3.3 V, V _O = V _{DD} or GND	4.5		7	pF
Z _O	Output impedance	High state V _O = 0.5 V _{DD} , V _O /I _{OH}	20	40	60	Ω
		Low state V _O = 0.5 V _{DD} , V _O /I _{OL}	20	31	60	

† All typical values are measured at their respective nominal V_{DD} values.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

PC1x, 3V66x (Type 5)

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V _{OH}	High-level output voltage	V _{DD} = min to max, I _{OH} = –1 mA	V _{DD} – 0.1 V			V
		V _{DD} = 3.135 V, I _{OH} = –18 mA	2.4			
V _{OL}	Low-level output voltage	V _{DD} = min to max, I _{OL} = 1 mA			0.1	V
		V _{DD} = 3.135 V, I _{OL} = 12 mA		0.15	0.4	
I _{OH}	High-level output current	V _{DD} = 3.135 V, V _O = 1 V	–33	–53		mA
		V _{DD} = 3.3 V, V _O = 1.65 V		–53		
		V _{DD} = 3.465 V, V _O = 3.135 V		–16	–33	
I _{OL}	Low-level output current	V _{DD} = 3.135 V, V _O = 1.95 V	30	67		mA
		V _{DD} = 3.3 V, V _O = 1.65 V		70		
		V _{DD} = 3.465 V, V _O = 0.4 V		27	49	
C _O	Output capacitance	V _{DD} = 3.3 V, V _O = V _{DD} or GND	4.5		7.5	pF
Z _O	Output impedance	High state V _O = 0.5 V _{DD} , V _O /I _{OH}	12	31	55	Ω
		Low state V _O = 0.5 V _{DD} , V _O /I _{OL}	12	24	55	

† All typical values are measured at their respective nominal V_{DD} values.

switching characteristics, V_{DD} = 3.135 V to 3.465 V, T_A = 0°C to 85°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Overshoot/undershoot			GND – 0.7 V		V _{DD} + 0.7 V	V
Ring back			V _{IL} – 0.1 V		V _{IH} + 0.1 V	V
Stabilization time, $\overline{\text{PWR_DWN}}$ to PC1x		f(CPU) = 133 MHz		0.05	3	ms
t _{dis3}	Disable time, $\overline{\text{PWR_DWN}}$ to PC1x	f(CPU) = 133 MHz		50		ns
Stabilization time, $\overline{\text{PWR_DWN}}$ to CPUx		f(CPU) = 133 MHz		0.03	3	ms
t _{dis4}	Disable time, $\overline{\text{PWR_DWN}}$ to CPUx	f(CPU) = 133 MHz		50		ns
Stabilization time†		After SEL1, SEL0			3	ms
		After power up			3	

† Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. In order for phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at X1. Until phase lock is obtained, the specifications for propagation delay and skew parameters given in the switching characteristics tables are not applicable. Stabilization time is defined as the time from when V_{DD} achieves its nominal operating level until the output frequency is stable and operating within specification.

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switching characteristics, $V_{DD} = 2.375\text{ V to }2.625\text{ V}$, $T_A = 0^\circ\text{C to }85^\circ\text{C}$ (continued)

CPUx

PARAMETER		FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{en1}	Output enable time	SEL133/100	CPUx	$f_{(CPU)} = 100\text{ or }133\text{MHz}$		6	10	ns
t_{dis1}	Output disable time	SEL133/100	CPUx	$f_{(CPU)} = 100\text{ or }133\text{MHz}$		8	10	ns
t_c	CPU clock period†			$f_{(CPU)} = 100\text{ MHz}$	10	10.04	10.2	ns
				$f_{(CPU)} = 133\text{ MHz}$	7.5	7.53	7.7	ns
Cycle to cycle jitter				$f_{(CPU)} = 100\text{ or }133\text{MHz}$			250	ps
Duty cycle				$f_{(CPU)} = 100\text{ or }133\text{MHz}$	45	55		%
$t_{sk(o)}$	CPU bus skew	CPUx	CPUx	$f_{(CPU)} = 100\text{ or }133\text{MHz}$	50		175	ps
$t_{sk(p)}$	CPU pulse skew	CPU _n	CPU _n	$f_{(CPU)} = 100\text{ or }133\text{MHz}$			2.2	ns
$t_{(off)}$	CPU clock to APIC clock offset, rising edge				1.5	2.8	4	ns
$t_{(off)}$	CPU clock to 3V66 clock offset, rising edge				0	0.75	1.5	ns
t_{w1}	Pulse duration width, high			$f_{(CPU)} = 100\text{ MHz}$	2.6	4.3		ns
				$f_{(CPU)} = 133\text{ MHz}$	1.4	3.7		
t_{w2}	Pulse duration width, low			$f_{(CPU)} = 100\text{ MHz}$	2.8	4.3		ns
				$f_{(CPU)} = 133\text{ MHz}$	1.7	4		
t_r	Rise time			$V_O = 0.4\text{ V to }2.0\text{ V}$	0.4	1.5	2.2	ns
t_f	Fall time			$V_O = 0.4\text{ V to }2.0\text{ V}$	0.4	1.4	2	ns

† The average over any 1- μs period of time is greater than the minimum specified period.

CPU_DIV2

PARAMETER		FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{en1}	Output enable time	SEL133/100	CPU_DIV2	$f_{(CPU)} = 100\text{ or }133\text{MHz}$		6	10	ns
t_{dis1}	Output disable time	SEL133/100	CPU_DIV2	$f_{(CPU)} = 100\text{ or }133\text{MHz}$		8	10	ns
t_c	CPU_DIV2 clock period†			$f_{(CPU)} = 100\text{ MHz}$	20	20.08	20.4	ns
				$f_{(CPU)} = 133\text{ MHz}$	15	15.06	15.3	ns
Cycle to cycle jitter				$f_{(CPU)} = 100\text{ or }133\text{MHz}$			250	ps
Duty cycle				$f_{(CPU)} = 100\text{ or }133\text{MHz}$	45	55		%
$t_{sk(p)}$	CPU_DIV2 pulse skew			$f_{(CPU)} = 100\text{ or }133\text{MHz}$			1.6	ns
t_{w1}	Pulse duration width, high			$f_{(CPU)} = 100\text{ MHz}$	7.1		ns	
				$f_{(CPU)} = 133\text{ MHz}$	4.7			
t_{w2}	Pulse duration width, low			$f_{(CPU)} = 100\text{ MHz}$	7.3	8.9		ns
				$f_{(CPU)} = 133\text{ MHz}$	5	6.6		
t_r	Rise time			$V_O = 0.4\text{ V to }2.0\text{ V}$	0.4	1.4	2	ns
t_f	Fall time			$V_O = 0.4\text{ V to }2.0\text{ V}$	0.4	1.3	1.8	ns

† The average over any 1- μs period of time is greater than the minimum specified period.



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switching characteristics, $V_{DD} = 2.375\text{ V to }2.625\text{ V}$, $T_A = 0^\circ\text{C to }85^\circ\text{C}$ (continued)

APIC

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{en1}	Output enable time	SEL133/100	APIC	$f_{(APIC)} = 16.67\text{ MHz}$			ns
t_{dis1}	Output disable time	SEL133/100	APIC	$f_{(APIC)} = 16.67\text{ MHz}$			ns
t_c	APIC clock period [†]			60	60.24	60.6	ns
	Cycle to cycle jitter		$f_{(CPU)} = 100\text{ or }133\text{ MHz}$			400	ps
	Duty cycle		$f_{(APIC)} = 16.67\text{ MHz}$	45		55	%
$t_{sk(p)}$	APIC pulse skew		$f_{(APIC)} = 16.67\text{ MHz}$			3	ns
$t_{(off)}$	APIC clock to CPU clock offset, rising edge	APIC	CPUx	-1.5		-4	ns
t_{w1}	Pulse duration width, high		$f_{(APIC)} = 16.67\text{ MHz}$	25.5	28		ns
t_{w2}	Pulse duration width, low		$f_{(APIC)} = 16.67\text{ MHz}$	25.3	29.2		ns
t_r	Rise time		$V_O = 0.4\text{ V to }2\text{ V}$	0.4	1.6	2.1	ns
t_f	Fall time		$V_O = 0.4\text{ V to }2\text{ V}$	0.4	1.2	1.7	ns

[†] The average over any 1- μs period of time is greater than the minimum specified period.

switching characteristics, $V_{DD} = 3.135\text{ V to }3.465\text{ V}$, $T_A = 0^\circ\text{C to }85^\circ\text{C}$

3V66

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{en1}	Output enable time	SEL133/100	3V66x	$f_{(3V66)} = 66\text{ MHz}$			ns
t_{dis1}	Output disable time	SEL133/100	3V66x	$f_{(3V66)} = 66\text{ MHz}$			ns
t_c	3V66 clock period [†]			15	15.06	15.3	ns
	Cycle to cycle jitter		$f_{(CPU)} = 100\text{ or }133\text{ MHz}$			400	ps
	Duty cycle		$f_{(3V66)} = 66\text{ MHz}$	45		55	%
$t_{sk(o)}$	3V66 bus skew	3V66x	3V66x		50	150	ps
$t_{sk(p)}$	3V66 pulse skew	3V66n	3V66n			2.6	ns
$t_{(off)}$	3V66 clock to CPU clock offset	3V66x	CPUx	0	-0.75	-1.5	ns
$t_{(off)}$	3V66 clock to PCI clock offset, rising edge			1.2	2.1	3	ns
t_{w1}	Pulse duration width, high		$f_{(3V66)} = 66\text{ MHz}$	5.2			ns
t_{w2}	Pulse duration width, low		$f_{(3V66)} = 66\text{ MHz}$	5			ns
t_r	Rise time		$V_O = 0.4\text{ V to }2\text{ V}$	0.5	1.5	2	ns
t_f	Fall time		$V_O = 0.4\text{ V to }2\text{ V}$	0.5	1.5	2	ns

[†] The average over any 1- μs period of time is greater than the minimum specified period.



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switching characteristics, $V_{DD} = 3.135\text{ V to }3.465\text{ V}$, $T_A = 0^\circ\text{C to }85^\circ\text{C}$ (continued)

48MHz

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
t_{en1}	Output enable time	SEL133/ $\overline{100}$	48MHz	$f_{(48\text{MHz})} = 48\text{ MHz}$		6	10	ns	
t_{dis1}	Output disable time	SEL133/ $\overline{100}$	48MHz	$f_{(48\text{MHz})} = 48\text{ MHz}$		8	10	ns	
t_c	48MHz clock period [†]			$f_{(48\text{MHz})} = 48\text{ MHz}$		20.5	20.83	21.1	ns
	Cycle to cycle jitter			$f_{(\text{CPU})} = 100\text{ or }133\text{ MHz}$			500	ps	
	Duty cycle			$f_{(48\text{MHz})} = 48\text{ MHz}$		45	55	%	
$t_{sk(p)}$	48MHz pulse skew	48MHz	48MHz	$f_{(48\text{MHz})} = 48\text{ MHz}$			3	ns	
t_{w1}	Pulse duration width, high			$f_{(48\text{MHz})} = 48\text{ MHz}$		7.8		ns	
t_{w2}	Pulse duration width, low			$f_{(48\text{MHz})} = 48\text{ MHz}$		7.8		ns	
t_r	Rise time			$V_O = 0.4\text{ V to }2\text{ V}$		1	2.1	2.8	ns
t_f	Fall time			$V_O = 0.4\text{ V to }2\text{ V}$		1	1.9	2.8	ns

[†] The average over any 1- μs period of time is greater than the minimum specified period.

REF

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
t_{en1}	Output enable time	SEL133/ $\overline{100}$	REFx	$f_{(\text{REF})} = 14.318\text{ MHz}$		6	10	ns	
t_{dis1}	Output disable time	SEL133/ $\overline{100}$	REFx	$f_{(\text{REF})} = 14.318\text{ MHz}$		8	10	ns	
t_c	REF clock period [†]			$f_{(\text{REF})} = 14.318\text{ MHz}$		69.84		ns	
	Cycle to cycle jitter			$f_{(\text{CPU})} = 100\text{ or }133\text{ MHz}$			700	ps	
	Duty cycle			$f_{(\text{REF})} = 14.318\text{ MHz}$		45	55	%	
$t_{sk(o)}$	REF bus skew	REFx	REFx	$f_{(\text{REF})} = 14.318\text{ MHz}$		150	250	ps	
$t_{sk(p)}$	REF pulse skew	REFn	REFn	$f_{(\text{REF})} = 14.318\text{ MHz}$			2	ns	
t_{w1}	Pulse duration width, high			$f_{(\text{REF})} = 14.318\text{ MHz}$		26.2	32.7	ns	
t_{w2}	Pulse duration width, low			$f_{(\text{REF})} = 14.318\text{ MHz}$		26.2	31.2	ns	
t_r	Rise time			$V_O = 0.4\text{ V to }2\text{ V}$		1	2	2.8	ns
t_f	Fall time			$V_O = 0.4\text{ V to }2\text{ V}$		1	1.9	2.8	ns

[†] The average over any 1- μs period of time is greater than the minimum specified period.



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switching characteristics, $V_{DD} = 3.135\text{ V to }3.465\text{ V}$, $T_A = 0^\circ\text{C to }85^\circ\text{C}$ (continued)

PCI

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{en1}	Output enable time	SEL133/100	PCIx	$f_{(PCI)} = 33\text{ MHz}$		6 10	ns
t_{dis1}	Output disable time	SEL133/100	PCIx	$f_{(PCI)} = 33\text{ MHz}$		8 10	ns
t_c	PCIx clock period [†]			$f_{(PCI)} = 33\text{ MHz}$		30 30.12 30.5	ns
	Cycle to cycle jitter			$f_{(CPU)} = 100\text{ or }133\text{ MHz}$		300	ps
	Duty cycle			$f_{(PCI)} = 33\text{ MHz}$		45 55	%
$t_{sk(o)}$	PCIx bus skew	PCIx	PCIx	$f_{(PCI)} = 33\text{ MHz}$		70 300	ps
$t_{sk(p)}$	PCIx pulse skew	PCIn	PCIn	$f_{(PCI)} = 33\text{ MHz}$		4	ns
$t_{(off)}$	PCIx clock to 3V66 clock offset			-1.2		-3	ns
t_{w1}	Pulse duration width, high			$f_{(PCI)} = 33\text{ MHz}$		12	ns
t_{w2}	Pulse duration width, low			$f_{(PCI)} = 33\text{ MHz}$		12	ns
t_r	Rise time			$V_O = 0.4\text{ V to }2\text{ V}$		0.5 1.6 2	ns
t_f	Fall time			$V_O = 0.4\text{ V to }2\text{ V}$		0.5 1.5 2	ns

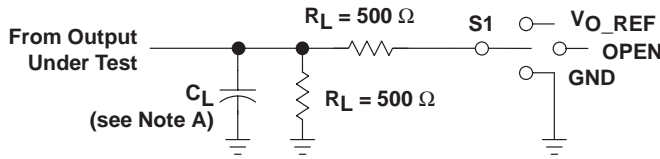
[†] The average over any 1- μs period of time is greater than the minimum specified period.



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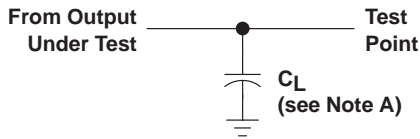
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PARAMETER MEASUREMENT INFORMATION

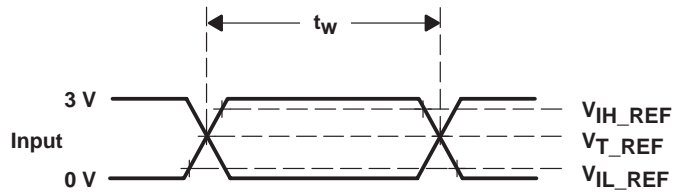


TEST	S1
tPLH/tPHL	Open
tPLZ/tPZL	VO_REF
tPHZ/tPZH	GND

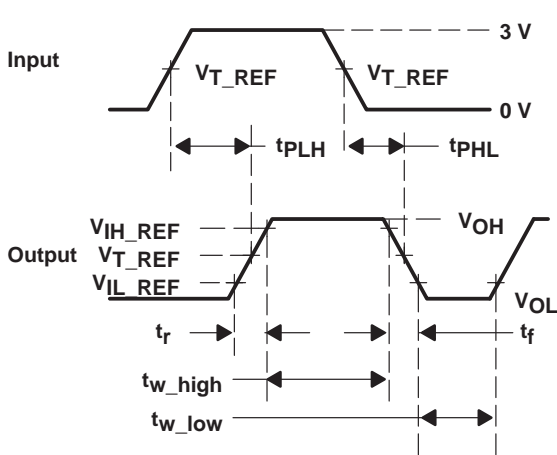
LOAD CIRCUIT for t_{pd} and t_{sk}



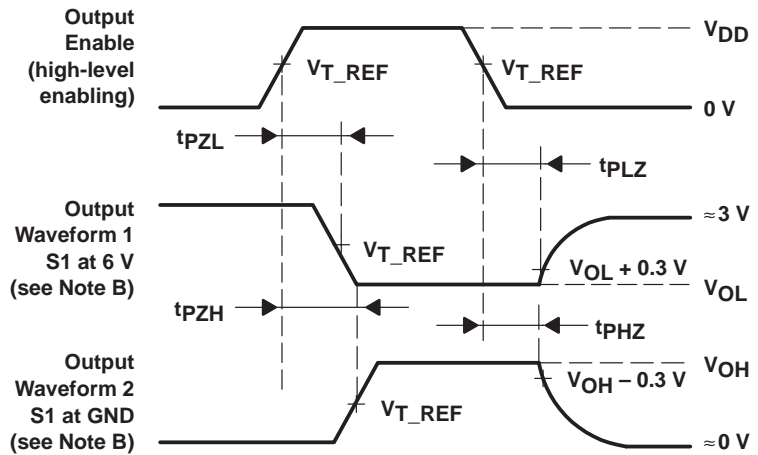
LOAD CIRCUIT FOR t_r and t_f



VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS

- NOTES: A. C_L includes probe and jig capacitance. C_L = 20 pF (CPUx, APIC, 48MHz, REF), C_L = 30 pF (PC1x)
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 14.318 MHz, Z_O = 50 Ω, t_r ≤ 2.5 ns, t_f ≤ 2.5 ns.
 D. The outputs are measured one at a time with one transition per measurement.

PARAMETER		3.3-V INTERFACE	2.5-V INTERFACE	UNIT
V _{IH_REF}	High-level reference voltage	2.4	2	V
V _{IL_REF}	Low-level reference voltage	0.4	0.4	V
V _{T_REF}	Input Threshold reference voltage	1.5	1.25	V
V _{O_REF}	Off-state reference voltage	6	4.6	V

Figure 3. Load Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION

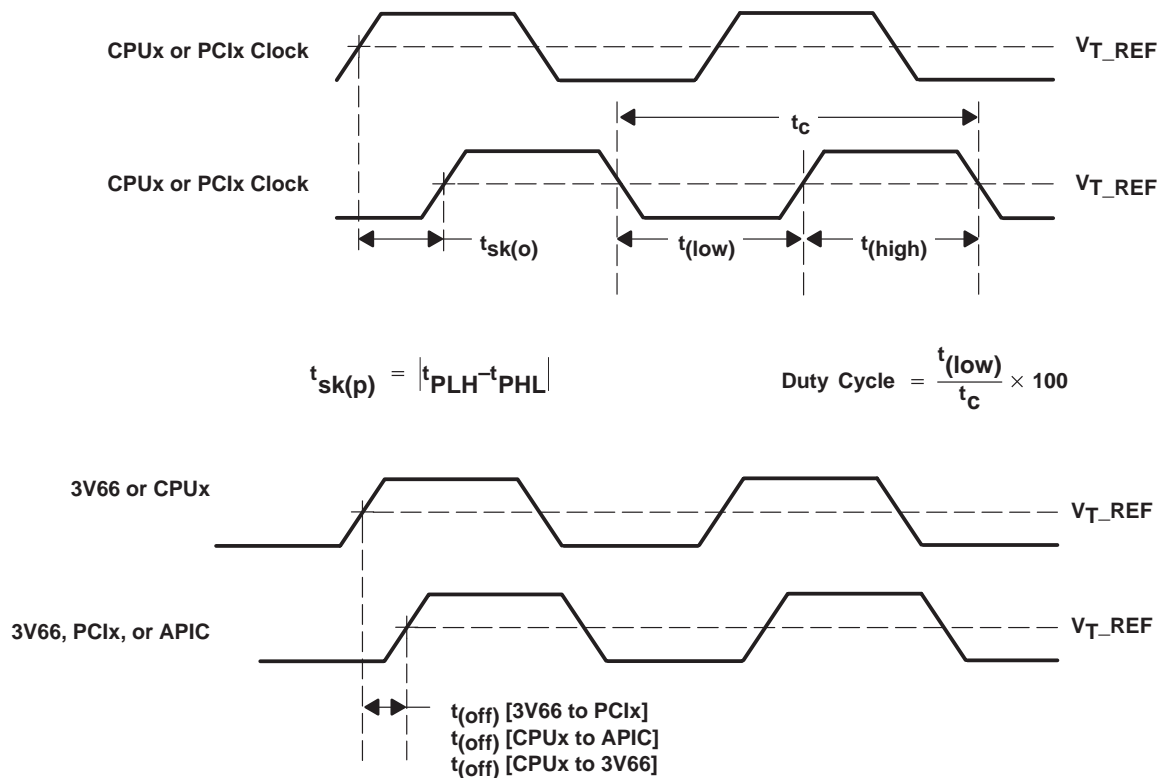
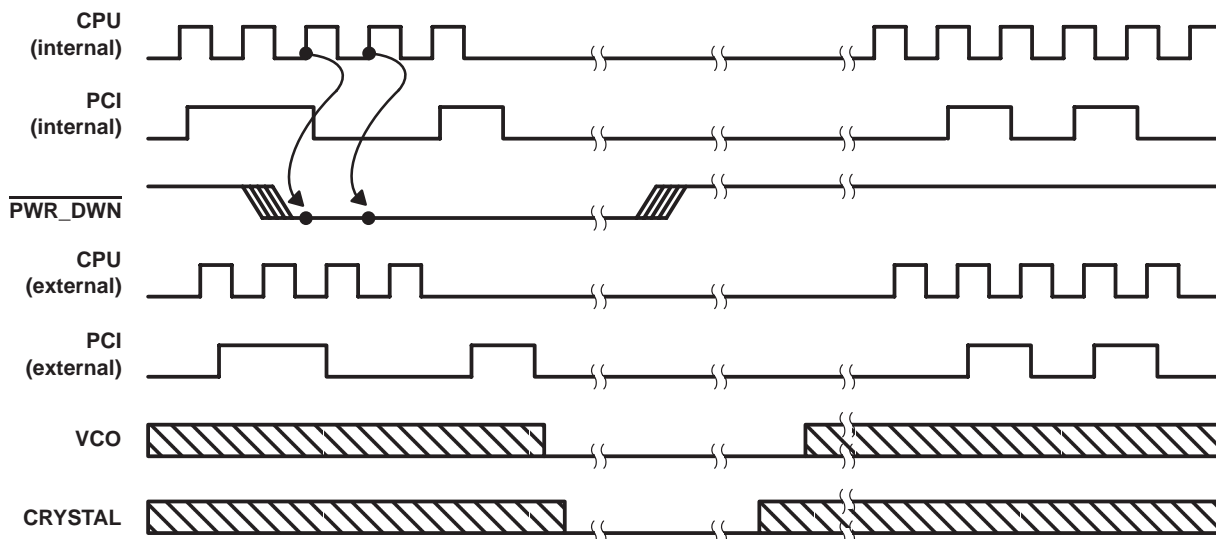


Figure 4. Waveforms for Calculation of Skew, Offset, and Jitter



NOTE A: Shaded sections on the VCO and Crystal waveforms indicate that the VCO and crystal oscillators are active and there is a valid clock.

Figure 5. Power-Down Timing

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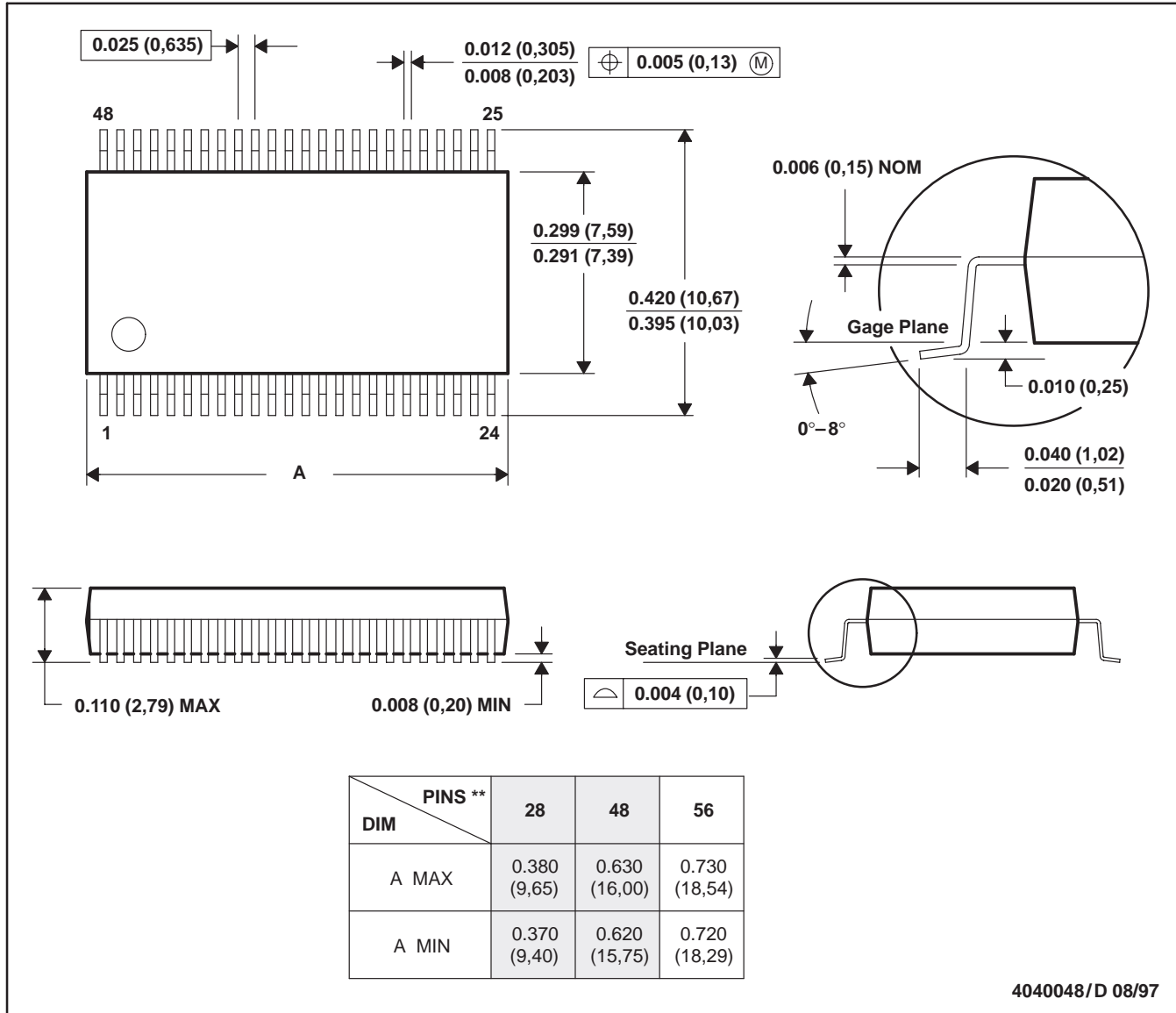
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MECHANICAL DATA

DL (R-PDSO-G)**

PLASTIC SMALL-OUTLINE PACKAGE

48-PIN SHOWN



- NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 D. Falls within JEDEC MO-118

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